



CERTIFICATE OF ACCREDITATION

The ANSI National Accreditation Board

Hereby attests that

Transcat – Denver
3251 Lewiston St., Suite 12
Aurora, CO 80011

Fulfills the requirements of

ISO/IEC 17025:2017

and the national standards

ANSI/NCSL Z540-1-1994 (R2002) AND
ANSI/NCSL Z540.3-2006 (R2013)

In the fields of

CALIBRATION & DIMENSIONAL MEASUREMENT

This certificate is valid only when accompanied by a current scope of accreditation document.
The current scope of accreditation can be verified at www.anab.org.

Jason Stine, Vice President

Expiry Date: 07 September 2025
Certificate Number: AC-2489.10



This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017.
This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory
quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).

SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017

AND

ANSI/NCSL Z540-1-1994 (R2002)

ANSI/NCSL Z540.3-2006 (R2013)

Transcat – Denver

3251 Lewiston St., Suite 12

Aurora, CO 80011

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CALIBRATION AND DIMENSIONAL MEASUREMENT

Valid to: September 7, 2025

Certificate Number: AC-2489.10

CALIBRATION

Acoustics and Vibration

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Acceleration	(0.5 to 1) Hz (1 to 5) Hz (5 to 10) Hz (10 to 99) Hz 100 Hz (101 to 920) Hz (921 to 5 000) Hz (5 001 to 10 000) Hz (10 to 15) kHz (15 to 20) kHz	1.1 % of reading 0.8 % of reading 0.8 % of reading 1.2 % of reading 0.75 % of reading 1 % of reading 1.4 % of reading 1.8 % of reading 2.2 % of reading 2.8 % of reading	Master Accelerometer

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Sine Wave Flatness ¹	Up to 3 V 10 Hz to 1 MHz (1 to 10) MHz (10 to 30) MHz (30 to 50) MHz (50 to 80) MHz (80 to 100) MHz	0.06 % of reading 0.1 % of reading 0.18 % of reading 0.41 % of reading 0.71 % of reading 0.84 % of reading	Thermal Converters, HP 3458A 8.5 Digit Multimeter

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
DC Current – Source ¹	Up to 2 pA (2 to 20) pA (20 to 200) pA (0.2 to 2) nA (2 to 20) nA (20 to 200) nA (0.2 to 2) μ A	0.8 % of reading + 10 fA 0.44 % of reading + 10 fA 0.3 % of reading + 30 fA 0.077 % of reading + 100 fA 0.076 % of reading + 1 pA 0.041 % of reading + 10 pA 0.029 % of reading + 0.1 nA	Keithley 263 Calibrator/Source
DC Current – Source ¹	(2 to 220) μ A (0.22 to 2.2) mA (2.2 to 22) mA (22 to 220) mA (0.22 to 2.2) A	40 μ A/A + 6 nA 36 μ A/A + 7 nA 35 μ A/A + 40 nA 48 μ A/A + 0.7 μ A 80 μ A/A + 12 μ A	Fluke 5730A Multiproduct Calibrator
	(2.2 to 11) A	0.036 % of reading + 0.48 mA	Fluke 5730A/5725A Multiproduct Calibrator with Amplifier
DC Current – Source ¹	(11 to 20.5) A	0.082 % of reading + 0.75 mA	Fluke 5520A Multiproduct Calibrator
DC Current – Source ¹	(1 to 10) A (10 to 100) A (100 to 300) A	0.01 % of reading 0.06 % of reading 0.12 % of reading	Guideline 9211 Multi-tap DC Current Shunt, Current Source
DC Clamp-on Ammeters (Non-Toroidal Type) Transformer Type Sensor ¹	(20 to 150) A (150 to 1 000) A	0.5 % of reading + 0.14 A 0.51 % of reading + 0.5 A	Fluke 5520A Multiproduct Calibrator, 5500A/COIL 50-turn Coil
DC Current – Measure ¹	Up to 2 pA (2 to 20) pA (20 to 200) pA (0.2 to 2) nA (2 to 20) nA (20 to 200) nA	2.1 % of reading + 6.6 fA 1.9 % of reading + 7 fA 1.9 % of reading + 10 fA 0.3 % of reading + 0.5 pA 0.3 % of reading + 1 pA 0.3 % of reading + 10 pA	Keithley 617 Programmable Electrometer
DC Current – Measure ¹	(0.2 to 1) μ A (1 to 10) μ A (10 to 100) μ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	25 μ A/A + 46 pA 25 μ A/A + 0.12 nA 33 μ A/A + 0.92 nA 29 μ A/A + 5.8 nA 29 μ A/A + 58 nA 46 μ A/A + 0.58 μ A 0.013 % of reading + 12 μ A	Agilent 3458A Opt 002 8.5 Digit Multimeter
DC Current – Measure ¹	(1 to 10) A (10 to 100) A (100 to 300) A	0.01 % of reading 0.06 % of reading 0.12 % of reading	Guideline 9211 Multi-tap DC Current Shunt, Digital Multimeter

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Current – Source ¹	Up to 220 μ A (10 to 20) Hz (20 to 40 Hz) 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.025 % of reading + 16 nA 0.016 % of reading + 10 nA 0.01 % of reading + 8 nA 0.028 % of reading + 12 nA 0.11 % of reading + 65 nA	Fluke 5730A Multiproduct Calibrator
	(0.22 to 2.2) mA (10 to 20) Hz (20 to 40 Hz) 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.025 % of reading + 40 nA 0.016 % of reading + 35 nA 0.01 % of reading + 35 nA 0.02 % of reading + 0.11 μ A 0.11 % of reading + 0.65 μ A	
	(2.2 to 22) mA (10 to 20) Hz (20 to 40 Hz) 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.025 % of reading + 0.4 μ A 0.016 % of reading + 0.35 μ A 0.01 % of reading + 0.35 μ A 0.02 % of reading + 0.55 μ A 0.11 % of reading + 5 μ A	
	(22 to 220) mA (10 to 20) Hz (20 to 40 Hz) 40 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.025 % of reading + 4 μ A 0.016 % of reading + 3.5 μ A 0.01 % of reading + 2.5 μ A 0.02 % of reading + 3.5 μ A 0.11 % of reading + 10 μ A	
	(0.22 to 2.2) A 20 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.024 % of reading + 35 μ A 0.045 % of reading + 80 μ A 0.7 % of reading + 0.16 mA	
	(2.2 to 3) A (10 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz	0.18 % of reading + 0.1 mA 0.06 % of reading + 0.1 mA 0.6 % of reading + 1 mA 2.5 % of reading + 5 mA	
	(3 to 11) A (45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	0.06 % of reading + 2 mA 0.1 % of reading + 2 mA 3 % of reading + 2 mA	
AC Current – Source ¹	(11 to 20.5) A (45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	0.12 % of reading + 5 mA 0.15 % of reading + 5 mA 3 % of reading + 5 mA	Fluke 5520A Multiproduct Calibrator

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Current – Source ¹ Extended Frequency Ranges	(29 to 330) μ A (10 to 30) kHz (0.33 to 3.3) mA (10 to 30) kHz (3.3 to 33) mA (10 to 30) kHz (33 to 330) mA (10 to 30) kHz	1.2 % of reading + 0.4 μ A 0.78 % of reading + 0.6 μ A 0.31 % of reading + 4 μ A 0.31 % of reading + 0.2 mA	Fluke 5520A Multiproduct Calibrator
AC Clamp-on Ammeters (Toroidal Type) Transformer Type Sensor ¹	(20 to 150) A (45 to 65) Hz (65 to 440) Hz (150 to 1 000) A (45 to 65) Hz (65 to 440) Hz	0.3 % of reading + 26 mA 0.83 % of reading + 47 mA 0.35 % of reading + 0.12 A 1.1 % of reading + 0.22 A	Fluke 5520A Multiproduct Calibrator, Fluke 5500A/COIL 50-turn Coil
AC Clamp-on Ammeters (Non-Toroidal Type) Hall Effect Sensor ¹	(20 to 150) A (45 to 65) Hz (65 to 440) Hz (150 to 1 000) A (45 to 65) Hz (65 to 440) Hz	0.57 % of reading + 0.25 A 1 % of reading + 0.25 A 0.6 % of reading + 0.9 A 1.3 % of reading + 0.92 A	Fluke 5520A Multiproduct Calibrator, Fluke 5500A/COIL 50-turn Coil
AC Current – Measure ¹	Up to 100 μ A (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 1 kHz (0.1 to 1) mA (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (1 to 10) mA (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz (10 to 100) mA (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz	0.46 % of reading + 35 nA 0.17 % of reading + 35 nA 0.072 % of reading + 35 nA 0.072 % of reading + 35 nA 0.46 % of reading + 0.23 μ A 0.17 % of reading + 0.23 μ A 0.07 % of reading + 0.23 μ A 0.038 % of reading + 0.23 μ A 0.46 % of reading + 2.3 μ A 0.17 % of reading + 2.3 μ A 0.071 % of reading + 2.3 μ A 0.038 % of reading + 2.3 μ A 0.48 % of reading + 23 μ A 0.17 % of reading + 23 μ A 0.071 % of reading + 23 μ A 0.037 % of reading + 23 μ A	Agilent 3458A Opt 002 8.5 Digit Multimeter

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Current – Measure ¹	(0.1 to 1) A (10 to 20) Hz (20 to 45) Hz (45 to 100) Hz 100 Hz to 5 kHz	0.46 % of reading + 0.23 mA 0.19 % of reading + 0.23 mA 0.097 % of reading + 0.23 mA 0.12 % of reading + 0.23 mA	Agilent 3458A Opt 002 8.5 Digit Multimeter
AC Current – Measure ¹	(1 to 20) A (50 to 100) Hz (100 to 300) Hz 300 Hz to 1 kHz (1 to 3) kHz (3 to 4) kHz (4 to 5) kHz	0.02 % of reading 0.03 % of reading 0.03 % of reading 0.06 % of reading 0.07 % of reading 0.09 % of reading	Fluke Y5020 Precision AC Current Shunt, Precision Digital Multimeter
AC Current – Measure ¹	(20 to 100) A (50 to 60) Hz 400 Hz 1 kHz	0.022 % of reading + 5 mA 0.026 % of reading + 5 mA 0.11 % of reading + 1.3 mA	100 A AC Current Shunt, Agilent 3458A 8.5 Digit Multimeter
AC Resistance – Measure ¹	1 kHz 20 Ω to 100 k Ω	0.039 % of reading + 10 m Ω	General Radio 1689 Precision LCR Meter
AC Resistance – Measure	50 Hz to 100 kHz (0.1 to 15) Ω 100 Hz to 100 kHz (15 to 420) Ω 100 Hz to 10 kHz (0.42 to 32) k Ω 100 Hz to 100 kHz (32 to 320) k Ω (0.32 to 10) M Ω	0.12 % of reading 0.06 % of reading 0.06 % of reading 0.06 % of reading 0.12 % of reading	Agilent 4284A Precision LCR Meter
AC Resistance – Measure	0.1 Ω 1 Ω 10 Ω 100 Ω 1 k Ω 10 k Ω 100 k Ω	0.17 % of reading 0.12 % of reading 0.12 % of reading 0.05 % of reading 0.05 % of reading 0.13 % of reading 0.26 % of reading	Comparison to Impedance Standards
DC Resistance – Source ¹ (Artifacts)	333 $\mu\Omega$ 1 m Ω 10 m Ω 100 m Ω	0.12 % of reading 0.06 % of reading 0.01 % of reading 0.01 % of reading	Guideline 9211 Precision Multi-tap DC Current Shunt
DC Resistance – Source ¹ (Artifacts)	1 Ω 10 k Ω	10 $\mu\Omega$ 54 m Ω	Fluke 742A Resistance Standard

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
DC Resistance – Source ¹ (Artifacts)	1 GΩ 10 GΩ 100 GΩ 1 TΩ	0.2 % of reading 0.5 % of reading 0.55 % of reading 0.56 % of reading	IET Labs HRRS-Q-8-100k-10 kV Precision Decade Resistor
DC Resistance – Source ¹ (Simulated-Fixed)	0 Ω 1 Ω 1.9 Ω 10 Ω 19 Ω 100 Ω 190 Ω 1 kΩ 1.9 kΩ 10 kΩ 19 kΩ 100 kΩ 190 kΩ 1 MΩ 1.9 MΩ 10 MΩ 19 MΩ 100 MΩ	40 μΩ 95 μΩ/Ω 95 μΩ/Ω 23 μΩ/Ω 23 μΩ/Ω 10 μΩ/Ω 10 μΩ/Ω 6.5 μΩ/Ω 6.5 μΩ/Ω 6.5 μΩ/Ω 6.5 μΩ/Ω 8.5 μΩ/Ω 8.5 μΩ/Ω 13 μΩ/Ω 18 μΩ/Ω 40 μΩ/Ω 47 μΩ/Ω 100 μΩ/Ω	Fluke 5730A Multiproduct Calibrator
DC Resistance – Measure ¹	Up to 10 Ω (10 to 100) Ω (0.1 to 1) kΩ (1 to 10) kΩ (10 to 100) kΩ (0.1 to 1) MΩ (1 to 10) MΩ (10 to 100) MΩ (0.1 to 1) GΩ	18 μΩ/Ω + 58 μΩ 15 μΩ/Ω + 0.58 mΩ 13 μΩ/Ω + 0.58 mΩ 12 μΩ/Ω + 5.8 mΩ 13 μΩ/Ω + 58 mΩ 21 μΩ/Ω + 2.3 Ω 62 μΩ/Ω + 0.12 kΩ 0.059 % of reading + 1.2 kΩ 0.82 % of reading + 12 kΩ	Agilent 3458A Opt 002 8.5 Digit Multimeter characterized with Standard Resistors.
DC Resistance – Measure ¹	(1 to 2) GΩ (2 to 20) GΩ (20 to 200) GΩ	1.7 % of reading + 0.1 MΩ 1.7 % of reading + 1 MΩ 1.8 % of reading + 10 MΩ	Keithley 617 Electrometer
DC Voltage – Source ¹	(0 to 220) mV (0.22 to 2.2) V (2.2 to 11) V (11 to 22) V (22 to 220) V	7.5 μV/V + 0.4 μV 5 μV/V + 0.7 μV 3.5 μV/V + 2.5 μV 3.5 μV/V + 4 μV 5 μV/V + 40 μV	Fluke 5730A Multiproduct Calibrator

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
DC Voltage – Source ¹	(220 to 1 100) V	6.5 $\mu\text{V/V}$ + 0.4 mV	Fluke 5730A Multiproduct Calibrator, Fluke 5725A Amplifier
DC High Voltage – Source ¹	(1.1 to 20) kV (20 to 36) kV	0.096 % of reading + 1.1 V 0.096 % of reading + 10 V	High Voltage Source, Vitretek 4700 Digital HV Meter, Vitretek HVL-100 High Voltage Probe
DC Voltage – Measure ¹	(0 to 100) mV (0.1 to 10) V (10 to 100) V (100 to 500) V (500 to 800) V (800 to 1 000) V	8.3 $\mu\text{V/V}$ + 0.58 μV 5.3 $\mu\text{V/V}$ + 0.58 μV 7.7 $\mu\text{V/V}$ + 35 μV 15 $\mu\text{V/V}$ + 0.12 mV 18 $\mu\text{V/V}$ + 0.12 mV 21 $\mu\text{V/V}$ + 0.12 mV	Agilent 3458A Opt 002 8.5 Digit Multimeter
DC High Voltage – Measure ¹	(1 to 5) kV (5 to 10) kV (10 to 20) kV (20 to 50) kV (50 to 70) kV (70 to 100) kV	0.04 % of reading + 0.26 V 0.04 % of reading + 1.7 V 0.065 % of reading + 1.1 V 0.066 % of reading + 10 V 0.067 % of reading + 28 V 0.069 % of reading + 81 V	Vitretek 4700 Digital HV Meter, Associated High Voltage Probes
AC Voltage – Source ¹	Up to 2.2 mV (10 to 20) Hz (20 to 40) Hz (0.04 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz (2.2 to 22) mV (10 to 20) Hz (20 to 40) Hz (0.04 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (0.5 to 1) MHz	0.024 % of reading + 4 μV 0.009 % of reading + 4 μV 0.008 % of reading + 4 μV 0.02 % of reading + 4 μV 0.05 % of reading + 5 μV 0.11 % of reading + 10 μV 0.14 % of reading + 20 μV 0.27 % of reading + 20 μV 0.024 % of reading + 4 μV 0.009 % of reading + 4 μV 0.008 % of reading + 4 μV 0.02 % of reading + 4 μV 0.05 % of reading + 5 μV 0.11 % of reading + 10 μV 0.14 % of reading + 20 μV 0.27 % of reading + 20 μV	Fluke 5730A Multiproduct Calibrator

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Source ¹	(22 to 220) mV		Fluke 5730A Multiproduct Calibrator
	(10 to 20) Hz	0.024 % of reading + 12 μ V	
	(20 to 40) Hz	0.009 % of reading + 7 μ V	
	40 Hz to 20 kHz	0.005 7 % of reading + 7 μ V	
	(20 to 50) kHz	0.012 % of reading + 7 μ V	
	(50 to 100) kHz	0.031 % of reading + 17 μ V	
	(100 to 300) kHz	0.066 % of reading + 20 μ V	
	(300 to 500) kHz	0.14 % of reading + 25 μ V	
	500 kHz to 1 MHz	0.27 % of reading + 45 μ V	
	(0.22 to 2.2) V		
	(10 to 20) Hz	0.024 % of reading + 40 μ V	
	(20 to 40) Hz	0.009 % of reading + 15 μ V	
	40 Hz to 20 kHz	0.004 2 % of reading + 8 μ V	
	(20 to 50) kHz	0.006 7 % of reading + 10 μ V	
	(50 to 100) kHz	0.008 5 % of reading + 30 μ V	
	(100 to 300) kHz	0.034 % of reading + 80 μ V	
	(300 to 500) kHz	0.1 % of reading + 0.2 mV	
	500 kHz to 1 MHz	0.17 % of reading + 0.3 mV	
	(2.2 to 22) V		
	(10 to 20) Hz	0.024 % of reading + 0.4 mV	
	(20 to 40) Hz	0.009 % of reading + 0.15 mV	
	40 Hz to 20 kHz	0.004 2 % of reading + 0.05 mV	
	(20 to 50) kHz	0.006 7 % of reading + 0.1 mV	
	(50 to 100) kHz	0.008 3 % of reading + 0.2 mV	
	(100 to 300) kHz	0.026 % of reading + 0.6 mV	
	(300 to 500) kHz	0.1 % of reading + 2 mV	
	500 kHz to 1 MHz	0.15 % of reading + 3.2 mV	
	(22 to 220) V		
	(10 to 20) Hz	0.024 % of reading + 4 mV	
	(20 to 40) Hz	0.009 % of reading + 1.5 mV	
	40 Hz to 20 kHz	0.005 2 % of reading + 0.6 mV	
	(20 to 50) kHz	0.008 % of reading + 1 mV	
	(50 to 100) kHz	0.015 % of reading + 2.5 mV	
	(100 to 300) kHz	0.09 % of reading + 16 mV	
	(300 to 500) kHz	0.44 % of reading + 40 mV	
	500 kHz to 1 MHz	0.8 % of reading + 80 mV	

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Source ¹	(220 to 750) V (30 to 50) kHz (50 to 100) kHz (220 to 1 100) V 40 Hz to 1 kHz (1 to 20) kHz (20 to 30) kHz	0.06 % of reading + 11 mV 0.23 % of reading + 45 mV 0.009 % of reading + 4 mV 0.017 % of reading + 6 mV 0.06 % of reading + 11 mV	Fluke 5730A Multiproduct Calibrator, Fluke 5725A Amplifier
AC Voltage – Measure ¹	Up to 1 mV 100 kHz to 1 MHz (1 to 3) MHz (3 to 10) MHz (10 to 20) MHz (1 to 3) mV 100 kHz to 1 MHz (1 to 3) MHz (3 to 10) MHz (10 to 20) MHz (3 to 100) mV 100 kHz to 1 MHz (1 to 3) MHz (3 to 10) MHz (10 to 20) MHz (20 to 30) MHz	1.8 % of reading + 2.4 μ V 3.5 % of reading + 2.4 μ V 9.3 % of reading + 2.4 μ V 23 % of reading + 2.4 μ V 0.97 % of reading + 2 μ V 3.5 % of reading + 2 μ V 9.3 % of reading + 2 μ V 23 % of reading + 2 μ V 0.91 % of reading + 3 μ V 1.8 % of reading + 3 μ V 2.9 % of reading + 3 μ V 6.9 % of reading + 3 μ V 14 % of reading + 3 μ V	Rohde & Schwarz URE3 RMS Voltmeter
AC Voltage – Measure ¹	Up to 10 mV (1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz (1 to 4) MHz (10 to 100) mV (1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz 300 kHz to 1 MHz	0.04 % of reading + 3.5 μ V 0.03 % of reading + 1.2 μ V 0.04 % of reading + 1.2 μ V 0.15 % of reading + 1.2 μ V 0.59 % of reading + 1.2 μ V 4.6 % of reading + 2.3 μ V 1.5 % of reading + 5.8 μ V 8.1 % of reading + 8.1 μ V 0.013 % of reading + 4 μ V 0.009 5 % of reading + 2 μ V 0.017 % of reading + 2 μ V 0.037 % of reading + 2 μ V 0.093 % of reading + 2 μ V 0.36 % of reading + 10 μ V 1.2 % of reading + 10 μ V	Agilent 3458A Opt 002 8.5 Digit Multimeter

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Measure ¹	(10 to 100) mV		Agilent 3458A Opt 002 8.5 Digit Multimeter
	(1 to 2) MHz	1.8 % of reading + 12 μ V	
	(2 to 4) MHz	4.7 % of reading + 81 μ V	
	(4 to 8) MHz	4.7 % of reading + 92 μ V	
	(8 to 10) MHz	17 % of reading + 0.12 mV	
	(0.1 to 1) V		
	(1 to 40) Hz	0.008 8 % of reading + 46 μ V	
	40 Hz to 1 kHz	0.008 3 % of reading + 23 μ V	
	(1 to 20) kHz	0.017 % of reading + 23 μ V	
	(20 to 50) kHz	0.036 % of reading + 23 μ V	
	(50 to 100) kHz	0.093 % of reading + 23 μ V	
	(100 to 300) kHz	0.35 % of reading + 0.12 mV	
	300 kHz to 1 MHz	1.2 % of reading + 0.12 mV	
	(1 to 2) MHz	1.8 % of reading + 0.12 mV	
	(2 to 4) MHz	4.6 % of reading + 0.81 mV	
	(4 to 8) MHz	4.6 % of reading + 0.92 mV	
	(8 to 10) MHz	17 % of reading + 1.2 mV	
	(1 to 10) V		
	(1 to 40) Hz	0.009 5 % of reading + 0.46 mV	
	40 Hz to 1 kHz	0.023 % of reading + 0.23 mV	
	(1 to 20) kHz	0.017 % of reading + 0.23 mV	
	(20 to 50) kHz	0.036 % of reading + 0.23 mV	
	(50 to 100) kHz	0.093 % of reading + 0.23 mV	
	(100 to 300) kHz	0.35 % of reading + 1.2 mV	
	300 kHz to 1 MHz	1.2 % of reading + 1.2 mV	
	(1 to 2) MHz	1.8 % of reading + 1.2 mV	
	(2 to 4) MHz	4.6 % of reading + 8.1 mV	
	(4 to 8) MHz	4.6 % of reading + 9.2 mV	
	(8 to 10) MHz	17 % of reading + 12 mV	
	(10 to 100) V		
	(1 to 40) Hz	0.024 % of reading + 4.6 mV	
	40 Hz to 1 kHz	0.024 % of reading + 2.3 mV	
	(1 to 20) kHz	0.024 % of reading + 2.3 mV	
	(20 to 50) kHz	0.041 % of reading + 2.3 mV	
	(50 to 100) kHz	0.14 % of reading + 2.3 mV	
	(100 to 300) kHz	0.46 % of reading + 12 mV	
	300 kHz to 1 MHz	1.7 % of reading + 12 mV	

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Measure ¹	(100 to 700) V (1 to 40) Hz 40 Hz to 1 kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz	0.048 % of reading + 46 mV 0.048 % of reading + 23 mV 0.071 % of reading + 23 mV 0.19 % of reading + 23 mV 0.35 % of reading + 23 mV	Agilent 3458A Opt 002 8.5 Digit Multimeter
AC High Voltage – Measure ¹	(0.7 to 5) kV (10 to 200) Hz (200 to 450) Hz (5 to 10) kV (10 to 200) Hz (200 to 450) Hz (10 to 20) kV (30 to 70) Hz (70 to 200) Hz (200 to 450) Hz (20 to 50) kV (30 to 70) Hz (70 to 200) Hz (200 to 450) Hz (50 to 70) kV (30 to 70) Hz (70 to 200) Hz	0.14 % of reading + 0.34 V 0.47 % of reading + 0.34 V 0.16 % of reading + 1.9 V 0.47 % of reading + 1.9 V 0.16 % of reading + 1.4 V 1.2 % of reading + 1.4 V 2.9 % of reading + 1.8 V 0.16 % of reading + 11 V 1.2 % of reading + 11 V 2.9 % of reading + 21 V 0.16 % of reading + 28 V 1.2 % of reading + 28 V	Vitretek 4700 Digital HV Meter, Associated High Voltage Probes
Capacitance – Source ¹ (Artifacts)	1 kHz (0.1 to 0.5) nF 0.5 nF to 1.4 μ F	0.59 pF 0.12 % of reading + 0.018 pF	Arco SS32 Capacitor Set
Capacitance – Source ¹ (Artifacts)	1 kHz to 1 MHz 1 pF 10 pF 100 pF 1 nF 120 Hz to 100 kHz 10 nF 100 nF 1 μ F	0.06 % of reading 0.004 % of reading 0.004 % of reading 0.007 % of reading 0.007 % of reading 0.007 % of reading 0.007 % of reading	HP 16380A Series Standard Air Capacitor Set
Capacitance – Source ¹ (Simulated)	10 Hz to 10 kHz (0.19 to 1.1) nF 10 Hz to 3 kHz (1.1 to 3.3) nF	0.39 % of reading + 7.8 pF 0.39 % of reading + 7.8 pF	Fluke 5520A Multiproduct Calibrator

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Capacitance – Source ¹ (Simulated)	10 Hz to 1 kHz (3.3 to 11) nF (11 to 110) nF (110 to 330) nF (10 to 600) Hz (0.33 to 1.1) μ F (10 to 300) Hz (1.1 to 3.3) μ F (10 to 150) Hz (3.3 to 11) μ F (10 to 120) Hz (11 to 33) μ F (10 to 80) Hz (33 to 110) μ F DC to 50 Hz (110 to 330) μ F DC to 20 Hz (0.33 to 1.1) mF DC to 6 Hz (1.1 to 3.3) mF DC to 2 Hz (3.3 to 11) mF DC to 0.6 Hz (11 to 33) mF DC to 0.2 Hz (33 to 110) mF	0.2 % of reading + 7.8 pF 0.2 % of reading + 78 pF 0.2 % of reading + 0.23 nF 0.2 % of reading + 0.78 nF 0.2 % of reading + 2.3 nF 0.2 % of reading + 7.8 nF 0.32 % of reading + 23 nF 0.35 % of reading + 78 nF 0.37 % of reading + 0.23 μ F 0.37 % of reading + 0.78 μ F 0.35 % of reading + 2.3 μ F 0.35 % of reading + 7.8 μ F 0.58 % of reading + 23 μ F 0.85 % of reading + 78 μ F	Fluke 5520A Multiproduct Calibrator
Capacitance – Measure ¹	1 kHz Up to 10 pF (10 to 100) pF (0.1 to 1) μ F (1 to 100) μ F (0.1 to 1) mF	0.47 % of reading + 0.05 pF 0.058 % of reading + 0.05 pF 0.024 % of reading + 0.05 pF 0.04 % of reading 0.24 % of reading	General Radio 1689 Precision LCR Meter
Capacitance – Measure ¹	1 MHz (10 to 90) pF 90 pF to 10 nF 100 kHz (12 to 90) pF 90 pF to 100 nF (0.1 to 100) μ F	0.12 % of reading 0.06 % of reading 0.12 % of reading 0.06 % of reading 0.12 % of reading	Agilent 4284A Precision LCR Meter

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Capacitance – Measure ¹	10 kHz (10 to 80) pF 80 pF to 1 μ F 400 Hz 10 nF to 10 μ F (100 to 120) Hz 10 nF to 100 μ F 100 μ F to 12 mF	0.12 % of reading 0.06 % of reading 0.06 % of reading 0.06 % of reading 0.12 % of reading	Agilent 4284A Precision LCR Meter
Inductance – Source ¹ (Artifact)	1 kHz 100 mH	0.14 mH	Standard Inductor
Inductance – Measure ¹	100 Hz to 1 kHz (1 to 100) mH (0.1 to 10) H 400 Hz 5 μ H to 5 mH 5 mH to 10 H (100 to 120) Hz (0.12 to 20) mH 20 mH to 10 H 1 kHz 1 μ H to 1 mH 10 kHz 5 nH to 120 μ H 120 μ H to 100 mH	0.04 % of reading + 0.1 μ H 0.057 % of reading + 1.4 μ H 0.12 % of reading 0.06 % of reading 0.12 % of reading 0.06 % of reading 0.12 % of reading 0.12 % of reading 0.06 % of reading	Agilent 4284A Precision LCR Meter
Oscilloscopes ¹ Amplitude – DC into 50 Ω load into 1 M Ω load Amplitude – Square Wave Rate: 10 Hz to 10 kHz into 50 Ω load into 1 M Ω load Rate: 10 Hz to 100 kHz into 50 Ω load into 1 M Ω load	(-5 to 5) V (-200 to 200) V 40 μ Vp-p to 1 mVp-p 1 mVp-p to 5 Vp-p 40 μ Vp-p to 1 mVp-p 1 mVp-p to 5 Vp-p 1 mVp-p to 200 Vp-p	0.023 % of reading + 19 μ V 0.023 % of reading + 19 μ V 0.78 % of reading + 7.8 μ V 0.078 % of reading + 7.8 μ V 0.78 % of reading + 7.8 μ V 0.16 % of reading + 7.8 μ V 0.78 % of reading + 7.8 μ V	Fluke 9500B Oscilloscope Calibrator, Fluke 9530 3.2 GHz Active Head, Fluke 9560 Active Head w/ 70 ps Capability

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Oscilloscopes ^{1,2}			
Time Markers			
100 mVp-p to 1 Vp-p	9.009 1 ns to 83 μ s	0.19 μ s/s	
into 50 Ω load	83 μ s to 55s	2.3 μ s/s	
Square Wave			
	450.5 ps to 9.009 ns	0.19 μ s/s	
Sine Wave			
	900.91 ns to 83 μ s	0.19 μ s/s	
	83 μ s to 55s	2.3 μ s/s	
Pulse			
	900.91 ns to 83 μ s	0.19 μ s/s	
	83 μ s to 55s	2.3 μ s/s	
Triangle Wave			
	83 μ s to 55 s	2.3 μ s	
Rise Time			
into 50 Ω load	5 mVp-p to 3 Vp-p		
Rate: 10 Hz to 2 MHz	500 ps (nominal)	290 ps	
	150 ps (nominal)	34 ps	
	25 mVp-p to 2 Vp-p		
Rate: 10 Hz to 1 MHz	70 ps (nominal)	21 ps	
	425 mVp-p to 575 mVp-p		
	25 ps (nominal)	5.7 ps	
	200 mVp-p		
	16 ps (nominal)	2.1 ps	
Leveled Sine Wave			
50 kHz Reference			
into 50 Ω load	5 mVp-p to 5 Vp-p		
	50 kHz to 10 MHz	1.2 % of reading	
Input Impedance Measure			
	(10 to 40) Ω	0.39 % of reading	
	(40 to 90) Ω	0.083 % of reading	
	(90 to 150) Ω	0.39 % of reading	
	(50 to 800) k Ω	0.39 % of reading	
	(0.8 to 1.2) M Ω	0.083 % of reading	
	(1.2 to 12) M Ω	0.39 % of reading	
Input Capacitance Measure			
	(1 to 35) pF	1.6 % of reading + 0.19 pF	
	(35 to 95) pF	2.3 % of reading + 0.19 pF	

Fluke 9500B
Oscilloscope Calibrator,
Fluke 9530
3.2 GHz Active Head,
Fluke 9550
Active Head w/ 25 ps
Capability,
Fluke 9560
Active Head w/ 70 ps
Capability,
Tektronix 067-1330-000
Calibration Fixture

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Phase – Source ¹	Up to 180° (10 to 65) Hz (65 to 500) Hz 500 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 20) kHz	0.11° 0.2° 0.4° 1.9° 3.9° 7.8°	Fluke 5520A Multiproduct Calibrator
DC Power – Source ¹ (0.33 to 330) mA	11 µW to 1.1 mW 1.1 mW to 0.11 W (0.11 to 110) W (110 to 330) W	0.024 % of reading 0.027 % of reading 0.024 % of reading 0.018 % of reading	Fluke 5520A Multiproduct Calibrator
(0.33 to 3) A	11 µW to 110 mW (0.11 to 990) W (0.99 to 3) kW	0.044 % of reading 0.053 % of reading 0.009 6 % of reading	
(3 to 20.5) A	99 mW to 0.99 W 0.99 W to 6.8 kW (6.8 to 20.5) kW	0.088 % of reading 0.07 % of reading 0.04 % of reading	
AC Power – Source ^{1,3} PF = 1	(3.3 to 9) mA (10 to 65) Hz (0.11 mW to 3) mW 3 mW to 9 W (9 to 33) mA (10 to 65) W (0.3 to 10) mW 10 mW to 33 W (33 to 90) mA (10 to 65) Hz (1 to 30) mW 30 mW to 90 W (90 to 330) mA (10 to 65) Hz (3 to 100) mW 100 mW to 300 W (0.33 to 0.9) A (10 to 65) Hz (11 to 300) mW (0.3 to 900) W (0.9 to 2.2) A (10 to 65) Hz (30 to 720) mW 0.72 W to 2 kW	0.13 % of reading 0.077 % of reading 0.089 % of reading 0.077 % of reading 0.071 % of reading 0.057 % of reading 0.089 % of reading 0.078 % of reading 0.071 % of reading 0.081 % of reading 0.089 % of reading 0.079 % of reading	Fluke 5520A Multiproduct Calibrator

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Power – Source ^{1,3} PF = 1 (2.2 to 4.5) A (4.5 to 20.5) A	(10 to 65) Hz 80 mW to 1.4 W 1.4 W to 4.5 kW (10 to 65) Hz 150 mW to 230 kW	0.088 % of reading 0.18 % of reading 0.17 % of reading	Fluke 5520A Multiproduct Calibrator
Electrical Simulation of Thermocouple Indicating Devices – Measure/Source ¹	Type B (250 to 350) °C (350 to 445) °C (445 to 580) °C (580 to 750) °C (750 to 1 000) °C (1 000 to 1 820) °C Type C (0 to 250) °C (250 to 1 000) °C (1 000 to 1 500) °C (1 500 to 1 800) °C (1 800 to 2 000) °C (2 000 to 2 250) °C (2 250 to 2 315) °C Type E (-270 to -245) °C (-245 to -195) °C (-195 to -155) °C (-155 to -90) °C (-90 to 0) °C (0 to 15) °C (15 to 890) °C (890 to 1 000) °C Type J (-210 to -180) °C (-180 to -120) °C (-120 to -50) °C (-50 to 990) °C (990 to 1 200) °C	1.2 °C 0.9 °C 0.71 °C 0.55 °C 0.45 °C 0.35 °C 0.24 °C 0.19 °C 0.21 °C 0.24 °C 0.27 °C 0.33 °C 0.37 °C 1.6 °C 0.24 °C 0.12 °C 0.095 °C 0.08 °C 0.076 °C 0.064 °C 0.074 °C 0.15 °C 0.12 °C 0.093 °C 0.08 °C 0.094 °C	Ectron 1140A Thermocouple Calibrator/Simulator

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Electrical Simulation of Thermocouple Indicating Devices – Measure/Source ¹	Type K		Ectron 1140A Thermocouple Calibrator/Simulator
	(-270 to -255) °C	2.5 °C	
	(-255 to -195) °C	0.85 °C	
	(-195 to -115) °C	0.16 °C	
	(-115 to -55) °C	0.12 °C	
	(-55 to 1 000) °C	0.087 °C	
	(1 000 to 1 372) °C	0.096 °C	
	Type N		
	(-270 to -260) °C	5.4 °C	
	(-260 to -200) °C	1.5 °C	
	(-200 to -140) °C	0.29 °C	
	(-140 to -70) °C	0.18 °C	
	(-70 to 25) °C	0.14 °C	
	(25 to 160) °C	0.12 °C	
	(160 to 1 300) °C	0.11 °C	
	Type R		
	(-50 to -30) °C	0.8 °C	
	(-30 to 45) °C	0.69 °C	
	(45 to 160) °C	0.49 °C	
	(160 to 380) °C	0.35 °C	
	(380 to 775) °C	0.3 °C	
	(775 to 1 768) °C	0.26 °C	
	Type S		
	(-50 to -30) °C	0.76 °C	
	(-30 to 45) °C	0.68 °C	
	(45 to 105) °C	0.49 °C	
	(105 to 310) °C	0.41 °C	
	(310 to 615) °C	0.35 °C	
	(615 to 1 768) °C	0.31 °C	
	Type T		
	(-270 to -255) °C	1.9 °C	
	(-255 to -240) °C	0.6 °C	
	(-240 to -210) °C	0.36 °C	
	(-210 to -150) °C	0.22 °C	
	(-150 to -40) °C	0.15 °C	
	(-40 to 100) °C	0.095 °C	
	(100 to 400) °C	0.08 °C	

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Bandwidth Flatness Measure ¹ into VSWR (1.2:1) (wrt Reference Frequency)	5 mVp-p to 5 Vp-p 100 Hz to 300 MHz (300 to 550) MHz 5 mVp-p to 3 Vp-p 550 MHz to 1.1 GHz (1.1 to 2.5) GHz 5 mVp-p to 2 Vp-p (2.5 to 3.2) GHz	1.6 % of reading 1.9 % of reading 2.7 % of reading 3.1 % of reading 3.1 % of reading	Fluke 9500B/3200 Oscilloscope Calibrator, Fluke 9530 3.2 GHz Active Head
Bandwidth Flatness Measure ¹ into VSWR (1.2:1)	5 mVp-p to 5 Vp-p 100 Hz to 300 MHz (300 to 550) MHz 5 mVp-p to 3 Vp-p 550 MHz to 1.1 GHz (1.1 to 2.5) GHz 5 mVp-p to 2 Vp-p (2.5 to 3) GHz 25 mVp-p to 2 Vp-p (3 to 6) GHz	1.6 % of reading 1.9 % of reading 2.3 % of reading 2.3 % of reading 2.3 % of reading 3.1 % of reading	Fluke 9500B/1100 Oscilloscope Calibrator, Fluke 9560 6 GHz Active Head
AC Voltage – Source ¹ Wide-Band Voltage (50 Ω)	30 Hz to 500 kHz (0.33 to 1.1) mV (1.1 to 3.3) mV (3.3 to 11) mV (11 to 33) mV (33 to 110) mV (110 to 330) mV (0.33 to 1.1) V (1.1 to 3.5) V	0.62 % of reading + 0.78 μ V 0.54 % of reading + 1.2 μ V 0.054 % of reading + 3.1 μ V 0.47 % of reading + 6.2 μ V 0.47 % of reading + 16 μ V 0.39 % of reading + 39 μ V 0.39 % of reading + 0.16 mV 0.31 % of reading + 0.19 mV	Fluke 5730A Multiproduct Calibrator
AC Voltage – Source ¹ Wide-Band Voltage (50 Ω) 1 kHz Reference	0.33 to 1.1) mV (10 to 30) Hz (30 to 119.99) Hz 120 Hz to 1.199 9 kHz (1.2 to 11.999) kHz (12 to 119.99) kHz 120 Hz to 1.199 9 MHz (1.2 to 2) MHz (2 to 11.9) MHz (12 to 20) MHz (20 to 30) MHz	0.23 % of reading 0.078 % of reading 0.078 % of reading 0.078 % of reading 0.078 % of reading 0.16 % of reading + 1.2 μ V 0.16 % of reading + 1.2 μ V 0.16 % of reading + 1.2 μ V 0.16 % of reading + 1.2 μ V 2.1 % of reading + 5.8 μ V	Fluke 5730A Multiproduct Calibrator

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Source ¹ Wide-Band Voltage (50 Ω) 1 kHz Reference	(1.1 to 3.3) mV		Fluke 5730A Multiproduct Calibrator
	(10 to 30) Hz	0.23 % of reading	
	(30 to 119.99) Hz	0.078 % of reading	
	120 Hz to 1.199 9 kHz	0.078 % of reading	
	(1.2 to 11.999) kHz	0.078 % of reading	
	(12 to 119.99) kHz	0.078 % of reading	
	120 Hz to 1.199 9 MHz	0.078 % of reading + 1.2 μ V	
	(1.2 to 2) MHz	0.078 % of reading + 1.2 μ V	
	(2 to 11.9) MHz	0.23 % of reading + 1.2 μ V	
	(12 to 20) MHz	0.39 % of reading + 1.2 μ V	
	(20 to 30) MHz	1.2 % of reading + 1.2 μ V	
	(3.3 to 11) mV		
	(10 to 30) Hz	0.23 % of reading	
	(30 to 119.99) Hz	0.078 % of reading	
	120 Hz to 1.199 9 kHz	0.078 % of reading	
	(1.2 to 11.999) kHz	0.078 % of reading	
	(12 to 119.99) kHz	0.078 % of reading	
	120 Hz to 1.199 9 MHz	0.078 % of reading + 1.2 μ V	
	(1.2 to 2) MHz	0.078 % of reading + 1.2 μ V	
	(2 to 11.9) MHz	0.16 % of reading + 1.2 μ V	
	(12 to 20) MHz	0.31 % of reading + 1.2 μ V	
	(20 to 30) MHz	0.78 % of reading + 1.2 μ V	
	(11 to 33) mV		
	(10 to 30) Hz	0.23 % of reading	
	(30 to 119.99) Hz	0.078 % of reading	
	120 Hz to 1.199 9 kHz	0.078 % of reading	
	(1.2 to 11.999) kHz	0.078 % of reading	
	(12 to 119.99) kHz	0.078 % of reading	
	120 Hz to 1.199 9 MHz	0.078 % of reading + 1.2 μ V	
	(11 to 16.5) mV		
	(1.2 to 2) MHz	0.16 % of reading + 1.2 μ V	
	(2 to 11.9) MHz	0.23 % of reading + 1.2 μ V	
	(12 to 20) MHz	0.39 % of reading + 1.2 μ V	
	(20 to 30) MHz	0.85 % of reading + 1.2 μ V	
	(16.5 to 33) mV		
	(1.2 to 2) MHz	0.078 % of reading + 1.2 μ V	
	(2 to 11.9) MHz	0.16 % of reading + 1.2 μ V	
	(12 to 20) MHz	0.31 % of reading + 1.2 μ V	
	(20 to 30) MHz	0.78 % of reading + 1.2 μ V	

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Source ¹ Wide-Band Voltage (50 Ω) 1 kHz Reference	(33 to 110) mV		Fluke 5730A Multiproduct Calibrator
	(10 to 30) Hz	0.23 % of reading	
	(30 to 119.99) Hz	0.078 % of reading	
	120 Hz to 1.199 9 kHz	0.078 % of reading	
	(1.2 to 11.999) kHz	0.078 % of reading	
	(12 to 119.99) kHz	0.078 % of reading	
	120 Hz to 1.199 9 MHz	0.078 % of reading + 1.2 μ V	
	(33 to 55) mV		
	(1.2 to 2) MHz	0.16 % of reading + 1.2 μ V	
	(2 to 11.9) MHz	0.23 % of reading + 1.2 μ V	
	(12 to 20) MHz	0.39 % of reading + 1.2 μ V	
	(20 to 30) MHz	0.85 % of reading + 1.2 μ V	
	(55 to 110) mV		
	(1.2 to 2) MHz	0.078 % of reading + 1.2 μ V	
	(2 to 11.9) MHz	0.16 % of reading + 1.2 μ V	
	(12 to 20) MHz	0.31 % of reading + 1.2 μ V	
	(20 to 30) MHz	0.78 % of reading + 1.2 μ V	
	(110 to 330) V		
	(10 to 30) Hz	0.23 % of reading	
	(30 to 119.99) Hz	0.078 % of reading	
	120 Hz to 1.199 9 kHz	0.078 % of reading	
	(1.2 to 11.999) kHz	0.078 % of reading	
	(12 to 119.99) kHz	0.078 % of reading	
	120 Hz to 1.199 9 MHz	0.078 % of reading + 1.2 μ V	
	(110 to 165) mV		
	(1.2 to 2) MHz	0.16 % of reading + 1.2 μ V	
	(2 to 11.9) MHz	0.23 % of reading + 1.2 μ V	
	(12 to 20) MHz	0.39 % of reading + 1.2 μ V	
	(20 to 30) MHz	0.85 % of reading + 1.2 μ V	
	(165 to 330) mV		
	(1.2 to 2) MHz	0.078 % of reading + 1.2 μ V	
	(2 to 11.9) MHz	0.16 % of reading + 1.2 μ V	
	(12 to 20) MHz	0.31 % of reading + 1.2 μ V	
	(20 to 30) MHz	0.78 % of reading + 1.2 μ V	
	(0.33 to 1.1) V		
	(10 to 30) Hz	0.23 % of reading	
	(30 to 119.99) Hz	0.078 % of reading	
	120 Hz to 1.199 9 kHz	0.078 % of reading	
	(1.2 to 11.999) kHz	0.078 % of reading	
	(12 to 119.99) kHz	0.078 % of reading	
	120 Hz to 1.199 9 MHz	0.078 % of reading + 1.2 μ V	

Electrical – DC/Low Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Voltage – Source ¹ Wide-Band Voltage (50 Ω) 1 kHz Reference	(0.33 to 0.55) V		Fluke 5730A Multiproduct Calibrator
	(1.2 to 2) MHz	0.16 % of reading + 1.2 μ V	
	(2 to 11.9) MHz	0.23 % of reading + 1.2 μ V	
	(12 to 20) MHz	0.39 % of reading + 1.2 μ V	
	(20 to 30) MHz	0.85 % of reading + 1.2 μ V	
	(0.55 to 1.1) V		
	(1.2 to 2) MHz	0.078 % of reading + 1.2 μ V	
	(2 to 11.9) MHz	0.16 % of reading + 1.2 μ V	
	(12 to 20) MHz	0.31 % of reading + 1.2 μ V	
	(20 to 30) MHz	0.78 % of reading + 1.2 μ V	
	(1.1 to 3.5) V		
	(10 to 30) Hz	0.23 % of reading	
	(30 to 119.99) Hz	0.078 % of reading	
	120 Hz to 1.199 9 kHz	0.078 % of reading	
	(1.2 to 11.999) kHz	0.078 % of reading	
	(12 to 119.99) kHz	0.078 % of reading	
	120 Hz to 1.199 9 MHz	0.078 % of reading + 1.2 μ V	
	(1.1 to 1.75) V		
	(1.2 to 2) MHz	0.16 % of reading + 1.2 μ V	
	(2 to 11.9) MHz	0.23 % of reading + 1.2 μ V	
	(12 to 20) MHz	0.39 % of reading + 1.2 μ V	
	(20 to 30) MHz	0.85 % of reading + 1.2 μ V	
	(1.75 to 3.5) V		
	(1.2 to 2) MHz	0.078 % of reading + 1.2 μ V	
	(2 to 11.9) MHz	0.16 % of reading + 1.2 μ V	
	(12 to 20) MHz	0.31 % of reading + 1.2 μ V	
	(20 to 30) MHz	0.78 % of reading + 1.2 μ V	

Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Amplitude Modulation – AM Depth Measure ¹ Rate: 50 Hz to 10 kHz Rate: 20 Hz to 10 kHz Rate: 50 Hz to 50 kHz Rate: 20 Hz to 100 kHz	(5 to 99) % Depth 150 kHz to 10 MHz (> 0 to 99) % Depth 150 kHz to 10 MHz (5 to 99) % Depth 10 MHz to 1.3 GHz (1.3 to 26.5) GHz (> 0 to 99) % Depth 10 MHz to 1.3 GHz (1.3 to 26.5) GHz	2.4 % Depth 3.5 % Depth 1.4 % Depth 1.9 % Depth 3.5 % Depth 3.5 % Depth	HP 8902A Measuring Receiver
Frequency Modulation – Measure ¹ Rate: 50 Hz to 10 kHz Rate: 50 Hz to 100 kHz Rate: 20 Hz to 200 kHz	≤ 40 kHz peak 250 kHz to 10 MHz ≤ 400 kHz peak 10 MHz to 26.5 GHz ≤ 400 kHz peak 10 MHz to 26.5 GHz	2.4 % Deviation 1.4 % Deviation 5.8 % Deviation	HP 8902A Measuring Receiver
Phase Modulation – Measure ¹ Rate: 200 Hz to 10 kHz Rate: 200 Hz to 20 kHz	< 40 rad Deviation 150 kHz to 10 MHz < 40 rad Deviation 10 MHz to 26.5 GHz	4.9 % Deviation 3.8 % Deviation	HP 8902A Measuring Receiver
Harmonic Distortion ¹	(-80 to 0) dBc 30 Hz to 6.5 GHz (6.5 to 22) GHz (22 to 26.5) GHz	1.7 dB 2.6 dB 3.4 dB	Agilent 8563E Spectrum Analyzer
Total Harmonic Distortion – Measure ¹	(-80 to 0) dB 20 Hz to 20 kHz (20 to 100) kHz	1.2 dB 2.3 dB	Agilent 8903B Audio Analyzer
AM Total Harmonic Distortion – Measure ¹	(-80 to 0) dB 20 Hz to 100 kHz	2.7 dB	Agilent 8903B Audio Analyzer

Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Total Harmonic Distortion – Measure ¹ Input Voltage Range 5 Hz to 1.2 MHz < 30 V	0.3 to 100) % THD 10 Hz to 1 MHz (1 to 3) MHz 0.1 % THD (10 to 20) Hz (20 to 30) Hz 30 Hz to 300 kHz (300 to 500) kHz 500 kHz to 1.2 MHz	3 % of reading 6 % of reading 12 % of reading 6 % of reading 3 % of reading 6 % of reading 12 % of reading	Agilent 334A Distortion Analyzer
Total Harmonic Distortion - Measure ¹ Input Voltage Range 5 Hz to 1.2 MHz > 30 V	(0.3 to 100) % THD 10 Hz to 300 kHz (300 to 500) kHz 500 kHz to 3 MHz 0.1 % THD (20 Hz to 30) Hz 30 Hz to 300 kHz (300 to 500) kHz 500 kHz to 1.2 MHz	3 % of reading 6 % of reading 12 % of reading 12 % of reading 3 % of reading 6 % of reading 12 % of reading	Agilent 334A Distortion Analyzer
Rise Time – Source ^{1,2}	≥ 14 ps	2.4 ps	Pulser
Rise Time – Measure	≥ 17 ps	3.9 ps	Sampling System
Absolute RF Power – Measure ¹	100 kHz to 2.6 GHz (-20 to -10) dBm (-10 to 0) dBm (0 to 10) dBm (10 to 20) dBm (20 to 30) dBm (2.6 to 12.2) GHz (-20 to -10) dBm (-10 to 0) dBm (0 to 10) dBm (10 to 20) dBm (20 to 30) dBm	0.11 dB 0.1 dB 0.11 dB 0.11 dB 0.23 dB 0.14 dB 0.13 dB 0.13 dB 0.14 dB 0.25 dB	Agilent 8902A Measuring Receiver, Agilent 11722A Power Sensor, Agilent 11792A Microwave Converter, Agilent 11793A Microwave Converter

Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Absolute RF Power – Measure ¹	(12.2 to 17.75) GHz (-20 to -10) dBm (-10 to 0) dBm (0 to 10) dBm (10 to 20) dBm (20 to 30) dBm (17.75 to 26.5) GHz (-20 to -10) dBm (-10 to 0) dBm (0 to 5) dBm	0.15 dB 0.14 dB 0.14 dB 0.15 dB 0.25 dB 0.18 dB 0.18 dB 0.18 dB	Agilent 8902A Measuring Receiver, Agilent 11722A Power Sensor, Agilent 11792A Microwave Converter, Agilent 11793A Microwave Converter
Tuned RF Absolute Power – Measure ¹	2.5 MHz to 26.5 GHz (-127 to -120) dB (-120 to -110) dB (-110 to -100) dB (-100 to -90) dB (-90 to -80) dB (-80 to -70) dB (-70 to -60) dB (-60 to -50) dB (-50 to -40) dB (-40 to -30) dB (-30 to -20) dB (-20 to -10) dB (-10 to 0) dB	0.26 dB 0.26 dB 0.26 dB 0.26 dB 0.26 dB 0.25 dB 0.25 dB 0.25 dB 0.25 dB 0.14 dB 0.14 dB 0.14 dB 0.14 dB	Agilent 8902A Opt 50 Measuring Receiver, Agilent 11722A Power Sensor, Agilent 11792A Microwave Converter, Agilent 11793A Microwave Converter
Tuned RF Relative Power – Measure ¹	2.5 MHz to 26 GHz (-127 to -120) dB (-120 to -110) dB (-110 to -100) dB (-100 to -90) dB (-90 to -80) dB (-80 to -70) dB (-70 to -60) dB (-60 to -50) dB (-50 to -40) dB (-40 to -30) dB (-30 to -20) dB (-20 to -10) dB (-10 to 0) dB	0.23 dB 0.23 dB 0.23 dB 0.23 dB 0.22 dB 0.084 dB 0.081 dB 0.074 dB 0.071 dB 0.068 dB 0.064 dB 0.06 dB 0.056 dB	Agilent 8902A Opt 50 Measuring Receiver, Agilent 11722A Power Sensor, Agilent 11792A Microwave Converter, Agilent 11793A Microwave Converter

Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Reflection (VSWR) ^{1,4} 10 MHz to 18 GHz	(Rho) 0.022 to 0.1 0.1 to 0.2 0.2 to 0.3 0.3 to 0.4	(Rho) 0.022 0.027 0.033 0.042	VSWR Bridge
RF Power – Measure ¹	10 MHz to 18 GHz (-30 to -20) dBm (-20 to 10) dBm (10 to 20) dBm	0.26 dB 0.1 dB 0.17 dB	EPM Power Meter, HP 8481A Power Sensor
	100 kHz to 4.2 GHz (-30 to -20) dBm (-20 to 10) dBm (10 to 20) dBm	0.26 dB 0.1 dB 0.17 dB	EPM Power Meter, HP 8482A Power Sensor
RF Power – Measure ¹	50 MHz to 18 GHz (-30 to -20) dBm (-20 to 10) dBm (10 to 20) dBm	0.26 dB 0.1 dB 0.17 dB	EPM Power Meter, HP 8485A Power Sensor
	(18 to 26.5) GHz (-30 to -20) dBm (-20 to 10) dBm (10 to 20) dBm	0.3 dB 0.18 dB 0.22 dB	
RF Power – Measure ¹	9 kHz to 6 GHz (-60 to -50) dBm	3.3 dB	EPM Power Meter, HP E9304A Power Sensor
	(-50 to -40) dBm	0.29 dB	
	(-40 to -10) dBm	0.17 dB	
	(-10 to 0) dBm	0.15 dB	
	(0 to 20) dBm	0.13 dB	
Amplitude Modulation – Measure ¹			Agilent E4440A PSA Spectrum Analyzer
Rate: 50 Hz to 10 kHz	(5 to 99) % Depth	1 % Depth	
Rate: 50 Hz to 100 kHz	100 kHz to 10 MHz		
	(20 to 99) % Depth	0.9 % Depth	
	10 MHz to 3 GHz		
	(5 to 20) % Depth	3 % Depth	
Rate: 20 Hz to 100 kHz	10 MHz to 3 GHz	5.2 % Depth	
	(3 to 26.5) GHz		
	(20 to 99) % Depth	1.9 % Depth	

Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Amplitude Modulation Distortion – Measure ¹ Rate: 20 Hz to 1 kHz	> 1% Depth 10 kHz to 10 MHz 10 MHz to 26.5 GHz	15 % of reading 16 % of reading	Agilent E4440A PSA Spectrum Analyzer
Frequency Modulation – Measure ¹ Rate: 20 Hz to 10 kHz	Deviation Rate > 0.2 250 kHz to 10 MHz Deviation Rate > 1.2 250 kHz to 10 MHz	1.8 % Deviation 1.3 % Deviation	Agilent E4440A PSA Spectrum Analyzer
Frequency Modulation – Measure ¹ Rate: 50 Hz to 200 kHz	Deviation Rate > 0.2 10 MHz to 6.6 GHz Deviation Rate > 0.45 10 MHz to 6.6 GHz Deviation Rate > 0.2 (6.6 to 13.2) GHz Deviation Rate > 0.8 (6.6 to 13.2) GHz Deviation Rate > 0.2 (13.2 to 26.5) GHz Deviation Rate > 16 (13.2 to 26.5) GHz	1.8 % Deviation 1.3 % Deviation 3 % Deviation 1.3 % Deviation 4.8 % Deviation 1.3 % Deviation	Agilent E4440A PSA Spectrum Analyzer
Frequency Modulation Distortion – Measure ¹ Rate: 20 Hz to 1 kHz	Deviation > 500 Hz 1 MHz to 6.6 GHz Deviation > 2.3 kHz (6.6 to 13.2) GHz Deviation > 2.7 kHz (13.2 to 26.5) GHz	14 % of reading 14 % of reading 14 % of reading	Agilent E4440A PSA Spectrum Analyzer

Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Phase Modulation – Measure ¹	> 0.7 rad 100 kHz to 6.6 GHz	1.3 % of reading	Agilent E4440A PSA Spectrum Analyzer
	> 0.3 rad 100 kHz to 6.6 GHz	3.5 % of reading	
	> 2 rad (6.6 to 13.2) GHz	1.3 % of reading	
	> 0.6 rad (6.6 to 13.2) GHz	3.5 % of reading	
	> 4 rad (13.2 to 26.5) GHz	1.3 % of reading	
	> 1.2 rad (13.2 to 26.5) GHz	3.5 % of reading	
Phase Modulation Distortion – Measure ¹ Rate: (20 to 500) Hz	> 0.8 rad 1 MHz to 6.6 GHz	16 % of reading	Agilent E4440A PSA Spectrum Analyzer
	> 1.8 rad (6.6 to 13.2) GHz	17 % of reading	
	> 3.5 rad (13.2 to 26.5) GHz	15 % of reading	
Phase Modulation Distortion – Measure ¹ Rate: 500 Hz to 1 kHz	> 0.4 rad 1 MHz to 6.6 GHz	15 % of reading	Agilent E4440A PSA Spectrum Analyzer
	> 0.8 rad (6.6 to 13.2) GHz	14 % of reading	
	> 1.2 rad (13.2 to 26.5) GHz	14 % of reading	
Tuned Relative RF Power – Measure ¹	100 kHz to 3.05 GHz		Agilent E4440A PSA Spectrum Analyzer
	(-120 to -110) dBm	0.17 dB	
	(-110 to -100) dBm	0.1 dB	
	(-100 to -90) dBm	0.09 dB	
	(-90 to -80) dBm	0.086 dB	
	(-80 to -70) dBm	0.081 dB	
	(-70 to -60) dBm	0.068 dB	
	(-60 to -50) dBm	0.063 dB	
	(-50 to -40) dBm	0.046 dB	
	(-40 to -30) dBm	0.041 dB	
	(-30 to -20) dBm	0.035 dB	
	(-20 to -10) dBm	0.03 dB	
	(-10 to 0) dBm	0.024 dB	

Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Tuned Relative RF Power – Measure ¹	(3.05 to 6.6) GHz (-120 to -110) dBm (-110 to -100) dBm (-100 to -90) dBm (-90 to -80) dBm (-80 to -70) dBm (-70 to -60) dBm (-60 to -50) dBm (-50 to -40) dBm (-40 to -30) dBm (-30 to -20) dBm (-20 to -10) dBm (-10 to 0) dBm	0.29 dB 0.1 dB 0.09 dB 0.086 dB 0.081 dB 0.068 dB 0.063 dB 0.046 dB 0.041 dB 0.035 dB 0.03 dB 0.024 dB	Agilent E4440A PSA Spectrum Analyzer
RF Power – Power Meter Reference	50 MHz 1 mW Reference	0.43 % of reading	HP 478A Thermistor, Agilent 3458A 8.5 Digit Multimeter, HP 432A Analog Power Meter
Tuned Relative RF Power – Measure ¹	(6.6 to 13.2) GHz (-110 to -100) dBm (-100 to -90) dBm (-90 to -80) dBm (-80 to -70) dBm (-70 to -60) dBm (-60 to -50) dBm (-50 to -40) dBm (-40 to -30) dBm (-30 to -20) dBm (-20 to -10) dBm (-10 to 0) dBm	0.25 dB 0.091 dB 0.086 dB 0.082 dB 0.077 dB 0.063 dB 0.058 dB 0.041 dB 0.035 dB 0.029 dB 0.023 dB	Agilent E4440A PSA Spectrum Analyzer

Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Tuned Relative RF Power – Measure ¹	(13.2 to 18) GHz		Agilent E4440A PSA Spectrum Analyzer
	(-110 to -100) dBm	0.61 dB	
	(-100 to -90) dBm	0.19 dB	
	(-90 to -80) dBm	0.086 dB	
	(-80 to -70) dBm	0.083 dB	
	(-70 to -60) dBm	0.077 dB	
	(-60 to -50) dBm	0.073 dB	
	(-50 to -40) dBm	0.062 dB	
	(-40 to -30) dBm	0.055 dB	
	(-30 to -20) dBm	0.036 dB	
	(-20 to -10) dBm	0.029 dB	
	(-10 to 0) dBm	0.024 dB	
	(18 to 26.5) GHz		
	(-100 to -90) dBm	0.45 dB	
	(-90 to -80) dBm	0.12 dB	
	(-80 to -70) dBm	0.082 dB	
	(-70 to -60) dBm	0.077 dB	
	(-60 to -50) dBm	0.072 dB	
	(-50 to -40) dBm	0.069 dB	
	(-40 to -30) dBm	0.054 dB	
	(-30 to -20) dBm	0.05 dB	
	(-20 to -10) dBm	0.029 dB	
	(-10 to 0) dBm	0.023 dB	
Tuned Absolute RF Power – Measure ¹	100 kHz to 3.05 GHz		Agilent E4440A PSA Spectrum Analyzer
	(-120 to -110) dBm	0.21 dB	
	(-110 to -100) dBm	0.15 dB	
	(-100 to -90) dBm	0.15 dB	
	(-90 to -80) dBm	0.15 dB	
	(-80 to -70) dBm	0.14 dB	
	(-70 to -60) dBm	0.14 dB	
	(-60 to -50) dBm	0.14 dB	
	(-50 to -40) dBm	0.13 dB	
	(-40 to -30) dBm	0.13 dB	
	(-30 to -20) dBm	0.13 dB	
	(-20 to -10) dBm	0.12 dB	
	(-10 to 0) dBm	0.12 dB	

Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Tuned Absolute RF Power – Measure ¹	(3.05 to 6.6) GHz		Agilent E4440A PSA Spectrum Analyzer
	(-120 to -110) dBm	0.32 dB	
	(-110 to -100) dBm	0.18 dB	
	(-100 to -90) dBm	0.18 dB	
	(-90 to -80) dBm	0.18 dB	
	(-80 to -70) dBm	0.17 dB	
	(-70 to -60) dBm	0.17 dB	
	(-60 to -50) dBm	0.17 dB	
	(-50 to -40) dBm	0.16 dB	
	(-40 to -30) dBm	0.16 dB	
	(-30 to -20) dBm	0.16 dB	
	(-20 to -10) dBm	0.16 dB	
	(-10 to 0) dBm	0.16 dB	
	(6.6 to 13.2) GHz		
	(-110 to -100) dBm	0.29 dB	
	(-100 to -90) dBm	0.18 dB	
	(-90 to -80) dBm	0.18 dB	
	(-80 to -70) dBm	0.17 dB	
	(-70 to -60) dBm	0.17 dB	
	(-60 to -50) dBm	0.17 dB	
	(-50 to -40) dBm	0.17 dB	
	(-40 to -30) dBm	0.16 dB	
	(-30 to -20) dBm	0.16 dB	
	(-20 to -10) dBm	0.16 dB	
	(-10 to 0) dBm	0.16 dB	
	(13.2 to 18) GHz		
	(-110 to -100) dBm	0.63 dB	
	(-100 to -90) dBm	0.24 dB	
	(-90 to -80) dBm	0.18 dB	
	(-80 to -70) dBm	0.18 dB	
	(-70 to -60) dBm	0.17 dB	
	(-60 to -50) dBm	0.17 dB	
	(-50 to -40) dBm	0.17 dB	
	(-40 to -30) dBm	0.16 dB	
	(-30 to -20) dBm	0.16 dB	
	(-20 to -10) dBm	0.16 dB	
	(-10 to 0) dBm	0.16 dB	

Electrical – RF/Microwave

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Tuned Absolute RF Power – Measure ¹	(18 to 26.5) GHz (-100 to -90) dBm (-90 to -80) dBm (-80 to -70) dBm (-70 to -60) dBm (-60 to -50) dBm (-50 to -40) dBm (-40 to -30) dBm (-30 to -20) dBm (-20 to -10) dBm (-10 to 0) dBm	0.51 dB 0.28 dB 0.26 dB 0.26 dB 0.26 dB 0.26 dB 0.26 dB 0.26 dB 0.26 dB 0.25 dB 0.25 dB	Agilent E4440A PSA Spectrum Analyzer

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Angle Measuring Devices ⁵	Up to 85°	1.5"	Master Angle Blocks
	90°	1.9"	Master Square
Micrometers, Calipers ^{1,5} (Outside, Inside, and Depth)	(0.05 to 48) in	(8+ 8L) μin	Gage Blocks
Anvil Flatness ¹	Up to 1 in	4.5 μin	Optical Flats
Indicators ^{1,5} (Dial and Digital)	Up to 0.05 in	28 μin	Dial Indicator Calibrator
	(0.05 to 5) in	(44 + 4L) μin	Horizontal Comparator
Length – Single Axis ⁵ Outside Measurement	Up to 5 in	(6 + 8L) μin	Horizontal Comparator
Inside Dimension	Up to 5 in	(22 + 3L) μin	
Height Measuring Equipment ^{1,5}	(0.4 to 8) in (8 to 48) in	(29 + 6L) μin (12 + 8L) μin	Gage Blocks
Cylindrical Plug Gages ⁵ Outside Diameter	Up to 5 in	(6 + 8L) μin	Horizontal Comparator
Cylindrical Pin Gages Outside Diameter	(0.004 to 1) in	36 μin	Laser Micrometer
Cylindrical Ring Gages ⁵ Inside Diameter	Up to 5 in	(22 + 3L) μin	Horizontal Comparator
Rulers, Tape Measures ⁵	Up to 16 in	(120 +10L) μin	Vision System

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Thread Plug Gages ⁵ Pitch Diameter 60°	Up to 1 in (1 to 3) in (3 to 5) in	79 µin 84 µin 94 µin	Universal Length Measuring System, Master Thread Wires
Major Diameter	Up to 5 in	(6 + 8L) µin	Horizontal Comparator
Thread Ring Gages Pitch Diameter	Up to 1 in (1 to 3) in (3 to 5) in	79 µin 84 µin 94 µin	Master Thread Plug Uncertainty

Mass and Mass Related

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Force Measuring Equipment	(1 to 200) lbf	0.06 % of reading	Deadweight
Torque Measuring Devices ¹ (Wrenches, Electronic, etc.)	(0.5 to 15) ozf·in (15 to 200) ozf·in (4 to 80) lbf·in (80 to 1 000) lbf·in (20 to 2 000) lbf·ft (1 000 to 5 000) lbf·ft	0.83 % of reading 0.4 % of reading 0.43 % of reading 0.4 % of reading 0.4 % of reading 1 % of reading	Torque Calibration System
Torque Calibration System (Analyzers, Transducers, etc.)	(0.5 to 16) ozf·in (1 to 40) lbf·in (40 to 260) lbf·in (260 to 3 000) lbf·in	0.83 % of reading 0.08 % of reading 0.07 % of reading 0.07 % of reading	Torque Wheels, Torque Arms, NIST Class F Weights
Torque Multipliers	(150 to 2 700) N·m (110 to 2 000) lbf·ft (2 700 to 4 000) N·m (2 000 to 3 000) lbf·ft (4 000 to 27 000) N·m (3 000 to 20 000) lbf·ft	1.1 % of reading 1.1 % of reading 1.3 % of reading 1.3 % of reading 1.4 % of reading 1.4 % of reading	Torque Calibration System
Hydraulic Torque Devices	(150 to 2 700) N·m (110 to 2 000) lbf·ft (2 700 to 4 000) N·m (2 000 to 3 000) lbf·ft (4 000 to 27 000) N·m (3 000 to 20 000) lbf·ft	1.1 % of reading 1.1 % of reading 1.3 % of reading 1.3 % of reading 1.3 % of reading 1.3 % of reading	Torque Calibration System

Mass and Mass Related

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Scales & Balances ^{1,6} (SI)	(5 to 500) mg (0.5 to 5) g (5 to 10) g (10 to 30) g 30 g to 9 kg (9 to 15) kg	12 µg 40 µg 58 µg 89 µg 0.000 32 % of reading 0.000 34 % of reading	ASTM E617 Class 1 weights and internal calibration procedure utilized for the calibration of the weighing system.
Scales & Balances ^{1,6} (SI)	Up to 100 mg (100 to 500) mg (0.5 to 5) g (5 to 10) g (10 to 20) g (20 to 30) g (30 to 100) g 100 g to 20 kg	16 µg 29 µg 58 µg 82 µg 0.12 mg 0.18 mg 0.35 mg 0.005 9 % of reading	ASTM E617 Class 2 weights and internal calibration procedure utilized for the calibration of the weighing system.
Scales & Balances ^{1,6} (Avoirdupois)	Up to 0.02 lb (0.02 to 1) lb (1 to 5) lb (5 to 977) lb	2.3 mg 0.041 % of reading 0.038 % of reading 0.036 % of reading	NIST Class F weights and internal calibration procedure utilized for the calibration of the weighing system.
Absolute Pressure Devices	Up to 25 psia (25 to 500) psia	0.001 9 psi 0.006 8 % of reading	Ruska 7250xi Pressure Controller/Calibrator
Pneumatic Pressure Gages	(-60 to -22) inH ₂ O (-22 to 22) inH ₂ O (22 to 60) inH ₂ O (60 to 72) inH ₂ O (72 to 804) inH ₂ O	0.009 % of reading + 0.000 15 inH ₂ O 0.002 2 inH ₂ O 0.009 % of reading + 0.000 15 inH ₂ O 0.006 7 inH ₂ O 0.009 % of reading + 0.000 15 inH ₂ O	DHI PPC4 Pressure Controller
Pneumatic Pressure Gages	(-14.7 to 25) psi (25 to 500) psig	0.001 6 psi 0.007 6 % of reading	Ruska 7250xi Pressure Controller/Calibrator
Pneumatic Pressure Gages	(10 to 3 000) psig (3 000 to 30 000) psig	0.38 psi 0.01 % of reading	Comparison to Fluke RPM 4 Reference Pressure Monitor
Hydraulic Pressure Gages	(5 to 15 000) psig	0.02 % of reading	Fluke P3125-PSI Oil Deadweight Tester

Thermodynamic

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Relative Humidity – Measure ¹	(10 to 30) °C (10 to 90) %RH	1.3 %RH	Temperature/Humidity Indicator/Probe
Relative Humidity – Source	(-10 to 15) °C (10 to 75) %RH (75 to 95) %RH (15 to 35) °C (10 to 95) %RH (35 to 70) °C (10 to 50) %RH (50 to 75) %RH (75 to 95) %RH	0.5 %RH 0.65 %RH 0.5 %RH 0.5 %RH 0.7 %RH 0.85 %RH	Two-pressure Humidity Generator
Temperature – Source ¹	(-25 to 140) °C (140 to 660) °C	0.06 °C 0.03 °C	AccuMac AM1760 Secondary SPRT, Hart 1575 Super Thermometer, Hart Drywell
Temperature – Measure ¹	(-195 to 0) °C (0 to 420) °C (420 to 660) °C	0.001 % of reading + 0.011 °C 0.001 % of reading + 0.025 °C 0.001 % of reading + 0.037 °C	AccuMac AM1760 Secondary SPRT, Hart Black Stack
	(-195 to 0) °C (0 to 420) °C (420 to 660) °C	0.001 % of reading + 0.01 °C 0.001 % of reading + 0.02 °C 0.001 % of reading + 0.031 °C	AccuMac AM1760 Secondary SPRT, Hart 1575 Super Thermometer
Infrared Temperature – Measuring Equipment ¹	(-15 to 0) °C (0 °C to 50) °C (50 °C to 100) °C (100 °C to 120) °C (120 °C to 200) °C (200 °C to 350) °C (350 °C to 500) °C	0.8 °C 0.65 °C 0.7 °C 0.76 °C 0.95 °C 1.6 °C 2.1 °C	Blackbody Source (Plate) $\epsilon = (0.9 \text{ to } 1)$ $\lambda = (8 \text{ to } 14) \mu\text{m}$

Time and Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Frequency – Source/Measure ¹	10 MHz	3.8 pHz/Hz	Fluke 910R GPS Frequency Standard
Stopwatches, Timers ¹	Up to 599 s/mon	58 ms/d	Vibrograf TM-4500 Timometer

Time and Frequency

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
AC Duty Cycle – Source ¹ Square Wave: < 3.3 Vp-p Freq: 0.1 Hz to 100 kHz	(1 to 10) % Duty Cycle 10 μs to 100 s (10 to 49) % Duty Cycle 10 μs to 100 s 50 % Duty Cycle 10 μs to 100 s (51 to 90) % Duty Cycle 10 μs to 100 s (90 to 99) % Duty Cycle 10 μs to 100 s	0.62 % of reading + 78 ns 0.039 % of reading + 78 ns 0.001 6 % of reading + 78 ns 0.039 % of reading + 78 ns 0.62 % of reading + 78 ns	Fluke 5522A Multiproduct Calibrator
Rotational Speed – Measure ¹	(10 to 999.9) rpm (1 000 to 99 999) rpm	0.058 % of reading + 0.12 rpm 0.082 % of reading + 1.2 rpm	Reflective Measure utilizing the Extech 461995 Photo Tachometer.

DIMENSIONAL MEASUREMENT

2 Dimensional

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Dimensional Measurement ⁵ 2D	X-Y Axis: Up to 16 in	(120 + 10L) μin	Vision System
Angles ⁵	Up to 2 in Up to 360° (2 to 16) in Up to 360°	0.072° (0.062 + 0.000 5L)°	Vision System

3 Dimensional

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Dimensional Measurement ⁵ 3D	X: Up to 24 in Y: Up to 24 in Z: Up to 24 in	(90 + 8.8L) μin	Zeiss CONTURA G2 Coordinate Measuring Machine utilized for Dimensional Measurement.

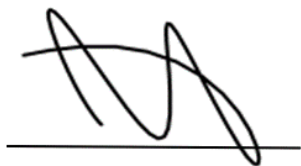
3 Dimensional

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
Dimensional Measurement ⁵ 3D	X: Up to 30 in Y: Up to 30 in Z: Up to 24 in	300 μ in	Zeiss CONTURA G2 Coordinate Measuring Machine utilized for Dimensional Measurement.
	X: Up to 39 in Y: Up to 36 in Z: Up to 24 in	390 μ in	
	X: Up to 39 in Y: Up to 48 in Z: Up to 24 in	430 μ in	
	X: Up to 39 in Y: Up to 54 in Z: Up to 24 in	450 μ in	
	X: Up to 39 in Y: Up to 62 in Z: Up to 24 in	490 μ in	

Calibration and Measurement Capability (CMC) is expressed in terms of the measurement parameter, measurement range, expanded uncertainty of measurement and reference standard, method, and/or equipment. The expanded uncertainty of measurement is expressed as the standard uncertainty of the measurement multiplied by a coverage factor of 2 ($k=2$), corresponding to a confidence level of approximately 95%.

Notes:

1. On-site calibration service is available for this parameter, since on-site conditions are typically more variable than those in the laboratory, larger measurement uncertainties are expected on-site than what is reported on the accredited scope.
2. The stated uncertainty is the laboratory's ability to source a fast rise pulse that is approximately 500 ps, 150 ps, 70 ps, and 25 ps. In the typical application of measuring rise time of an oscilloscope, this value is one of the contributing factors, but other factors are derived from the DUT. The known source rise time is mathematically removed from the total measured rise time measured on the DUT.
3. The uncertainties shown are for the most favorable conditions. There is an increase in uncertainty that corresponds to the laboratory's AC voltage and current uncertainties at different frequencies other than the ones shown. Power factors (PF) other than the one shown contribute to the power uncertainty. PF is related to the cosine of phase. Therefore, uncertainties track the laboratory's phase uncertainty closely at PF near one but are magnified heavily as PF approaches zero. The lab may also report reactive power, apparent power, and power factor under this accreditation. If needed, contact laboratory for more information regarding uncertainties at frequency and power factor combinations other than the ones shown.
4. This parameter is a unitless measurement.
5. " = arc-minute; L = length in inches.
6. The CMC for scales and balances is highly dependent upon the resolution of the unit under test. The CMC presented here does not include the resolution of the unit under test. The resolution will be included in the reported measurement uncertainty at the time of calibration.
7. This scope is formatted as part of a single document including Certificate of Accreditation No. AC-2489.10.



Jason Stine, Vice President